

Notice of References Cited	Application/Control No. 09/642,596	Applicant(s)/Patent Under Reexamination DANIELSON, J. D. SHELDON	
	Examiner Richard Hanig	Art Unit 2873	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5757013	05-1998	Groger et al	250/458.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Vadde et al, A closed loop scheme for phase-sensitive fluorometry, Rev. Sci. Instrum. 66 (7), July 1995, p.3750.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.